Notice of References Cited Application/Control No. 10/060,567 Examiner Tae H Yoon Applicant(s)/Patent Under Reexamination KOCHVAR ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-Re 34988	07-1995	Yang et al	252/90
	В	US-2003/0139312 A1	07-2003	Caswell et al.	510/320
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-		,	
	1	US-			
	J	US-			
	K ·	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	P					
	Q					
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	S					
	Т				·	

NON-PATENT DOCUMENTS

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